

Application/Control N	lo. Applicant(s)/Patent under Reexamination	
10/624,932	TAUPIER ET AL.	
Examiner	Art Unit	
Christopher J. Nichol	ls, Ph.D. 1647	

SEARCHED					
Class	Subclass	Date	Examiner		
435	69.1 70.1 252.3 254.2 325	3/15/2005	CJN		
536	23.5				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
INVENTORS (PALM/WEST) WEST (USPT, PGPUBS,US OCR, EPO, JPO, DERWENT) NCBI (PUBMED) STN (BIOSCIENCE)	3/15/2005	CJN
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